Search Notes

Application/Control No.	Ontrol No.  Applicant(s)/Patent under Reexamination	
10/694,797	SHIMIZU ET AL.	
Examiner	Art Unit	
Luan K. Bui	3728	

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SEARCHED					
Class	Subclass	Date	Examiner		
206	205	8/17/2005	LKB		
	213.1				
	524.8				
347	2, 28				
	86, 108				
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INTERFERENCE SEARCHED				
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